Form PTO 1449 (Modified)	1	U.S. DEPARTMENT PATENT AND TRA	OF COMMERCE	ATTY DOCKET NO.			SERIAL NO.							
	Wall Wall Wall Wall Wall Wall Wall Wall			217870US6PCT			10/048,164							
LIST OF	. DEEC	RENCES CITED BY AF	ODI ICANIT	APPLICANT										
LIGITOR	NEFE	RENCES CITED BY AP	PLICANT	Shinobu KURIYA, et al.										
					FILING DATE January 29, 2002			GROUP						
		_		1st RCE FILED August 28, 2006			2134							
	U.S. PATENT DOCUMENTS													
EXAMINER INITIAL		DOCUMENT NUMBER	DATE		NAME CLASS			SUB FILING DATE CLASS IF APPROPRIATE						
	AA	TVO III DET				-	CLASS IF APPROPRIATE							
	AB				· · · · · · · · · · · · · · · · · · ·	ļ								
	AC													
	AD													
	AE		-			 								
	AF		-											
	AG		 											
	AH		+											
***	Al				 	ļ		-						
	AJ		 		·····									
	AK													
	AL					-								
	AM		-			<u> </u>	_							
	AN													
	1	L												
			FO	REIGN PATENT	DOCUMENTS									
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO								
/MH/	AO	JP 7-104993	04/21/1995	JAPAN (with English Abstract and Unedited Computer-Generated English Translation)			х							
/MH/	AP	JP 10-269144	10/09/1998	JAPAN (with English Abstract and Unedited Computer-Generated English Translation)			X							
/MH/	AQ	JP 11-345261	12/14/1999	JAPAN (with English Abstract and Unedited			×							
	AR			GOTTPULCI-GOTTE	Computer-Generated English Translation)									
	AS				· · · · · · · · · · · · · · · · · · ·									
	AT													
	AU													
	AV		1	· · · · · · · · · · · · · · · · · · ·										
		OTHER RE	FERENCES (I	ncluding Author	, Title, Date, Pertinent	Pages, et	c.}							
	Aw													
			<u>. </u>											
	AX													
1	AY													
	AZ					Additi	ional Refer	ences sheet(s) attached						
Examiner	/Matth	tthew Heneghan/					Date Considered 05/02/2007							
Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.														

	-1-17-17-17											
Form PTO 1449 (Modified)		U.S. DEPARTMENT (PATENT AND TRAD	OF COMMERCE EMARK OFFICE	ATTY DOCKET NO. 3 JUL 1 3 200	3	SERIAL N						
			217870US6PCT	10/048,164								
LICTOF	05550	CNOSS CITED BY AD	DUCANT	APPLICANT RADEMARK								
LIST OF	KEFER	RENCES CITED BY API	PLICANI	Shinobu KURIYA, et al.								
				FILING DATE	GROUP							
				January 29, 2002		2181						
U.S. PATENT DOCUMENTS												
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE					
	AA											
	AB											
	AC					RFO	FIVED					
	AD				<u> </u>	-6-6						
	AE					JUL	1 4 2004					
	AF				Т,	chaola	ou Conter 2100					
	AG				16		gy Center 2190					
	АН											
	Al											
	AJ											
	AK											
	AL											
	AM											
)	AN				<u> </u>	<u> </u>						
			FC	REIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY		YE	TRANSLATION S NO					
· · /MH/	AO.	WO 00/08909	02/24/2000	WIPO	• • •							
/MH/	AP	0 715 244	06/05/1996	EUROPE								
	AQ											
	AR	Ì.										
	AS											
	AT											
	AU											
	AV											
		OTHER R	EFERENCES	(Including Author, Title, Date, Pertinen	it Pages, e	etc.)						
	A14.	1										
	AW											
	AX						,, 					
	AY				-							
	AZ				Add	ditional Ref	ferences sheet(s) attached					
Examiner	/Ma	atthew Heneghan/		Date Considered 05/03/2007								
*Examiner: I	*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.											
Consumance and not considered, include copy of this form with next continuincation to applicant.												